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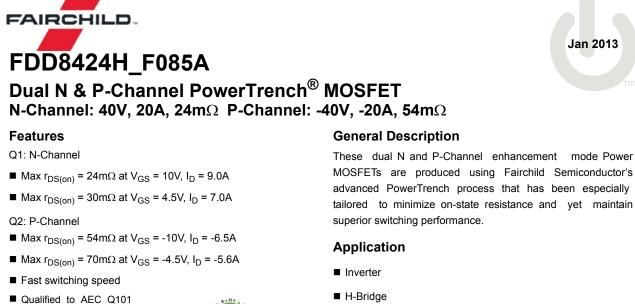


ON Semiconductor®

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Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild_questions@onsemi.com.

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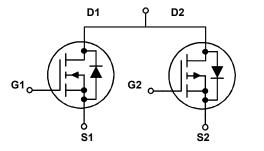


RoHS Compliant



N-Channel





P-Channel

Dual DPAK 4L

MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units	
V _{DS}	Drain to Source Voltage		40	-40	V	
V _{GS}	Gate to Source Voltage		±20	±20	V	
	Drain Current - Continuous (Package Limited)		20	-20		
,	- Continuous (Silicon Limited)	T _C = 25°C	26	-20	A	
I _D	- Continuous	T _A = 25°C	9.0	-6.5		
	- Pulsed		55	-40		
	Power Dissipation for Single Operation	$T_C = 25^{\circ}C$ (Note 1)	30	35		
P _D	$T_A = 25^{\circ}C$ (Note 1a)		3.1		W	
		$T_A = 25^{\circ}C$ (Note 1b)	1.3		1	
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	29	33	mJ	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to	+150	°C	

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case, Single Operation for Q1	(Note 1)	4.1	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Single Operation for Q2	(Note 1)	3.5	C/vv

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD8424H	FDD8424H_F085A	TO-252-4L	13"	12mm	2500 units

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Jan 2013

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Chara	acteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	I_D = 250µA, V_{GS} = 0V I_D = -250µA, V_{GS} = 0V	Q1 Q2	40 -40			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu$ A, referenced to 25°C $I_D = -250\mu$ A, referenced to 25°C	Q1 Q2		34 -32		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 32V, V_{GS} = 0V$ $V_{DS} = -32V, V_{GS} = 0V$	Q1 Q2			1 -1	μA
I _{GSS}	Gate to Source Leakage Current	V_{GS} = ±20V, V_{DS} = 0V	Q1 Q2			±100 ±100	nA nA
On Chara	cteristics						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = -250 \mu A$	Q1 Q2	1 -1	1.7 -1.6	3 -3	V
$\frac{\Delta V_{\text{GS(th)}}}{\Delta T_{\text{J}}}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250µA, referenced to 25°C I_D = -250µA, referenced to 25°C	Q1 Q2		-5.3 4.8		mV/°C
	S(on) Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 9.0A$ $V_{GS} = 4.5V, I_D = 7.0A$ $V_{GS} = 10V, I_D = 9.0A, T_J = 125^{\circ}C$	Q1		19 23 29	24 30 37	
r _{DS(on)}		$V_{GS} = -10V, I_D = -6.5A$ $V_{GS} = -4.5V, I_D = -5.6A$ $V_{GS} = -10V, I_D = -6.5A, T_J = 125^{\circ}C$	Q2		42 58 62	54 70 80	- mΩ
9 _{FS}	Forward Transconductance	$V_{DS} = 5V, I_D = 9.0A$ $V_{DS} = -5V, I_D = -6.5A$	Q1 Q2		29 13		S
Dynamic	Characteristics						
C _{iss}	Input Capacitance	Q1 V _{DS} = 20V, V _{GS} = 0V, f = 1MHZ	Q1 Q2		750 1000	1000 1330	pF
C _{oss}	Output Capacitance	Q2	Q1 Q2		115 140	155 185	pF
C _{rss}	Reverse Transfer Capacitance	V _{DS} = -20V, V _{GS} = 0V, f = 1MHZ	Q1 Q2		75 75	115 115	pF
R _g	Gate Resistance	f = 1MHz	Q1 Q2		1.1 3.3		Ω
Switching	g Characteristics						
t _{d(on)}	Turn-On Delay Time	Q1	Q1 Q2		7 7	14 14	ns
t _r	Rise Time	V_{DD} = 20V, I_D = 9.0A, V_{GS} = 10V, R_{GEN} = 6 Ω	Q1 Q2		13 3	24 10	ns
t _{d(off)}	Turn-Off Delay Time	Q2 V _{DD} = -20V, I _D = -6.5A,	Q1 Q2		17 20	31 36	ns
t _f	Fall Time	$V_{\rm GS} = -10V, R_{\rm GEN} = 6\Omega$	Q1 Q2		6 3	12 10	ns
Q _{g(TOT)}	Total Gate Charge	Q1	Q1 Q2		14 17	20 24	nC
Q _{gs}	Gate to Source Charge	V _{GS} = 10V, V _{DD} = 20V, I _D = 9.0A Q2	Q1 Q2		2.3 3.0		nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{GS} = -10V, V _{DD} = -20V, I _D = -6.5A	Q1 Q2		3.2 3.6		nC

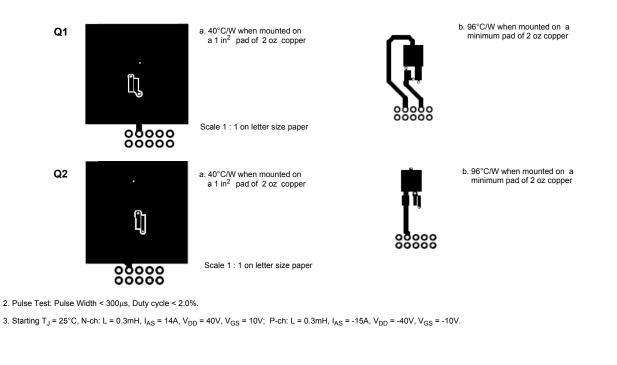
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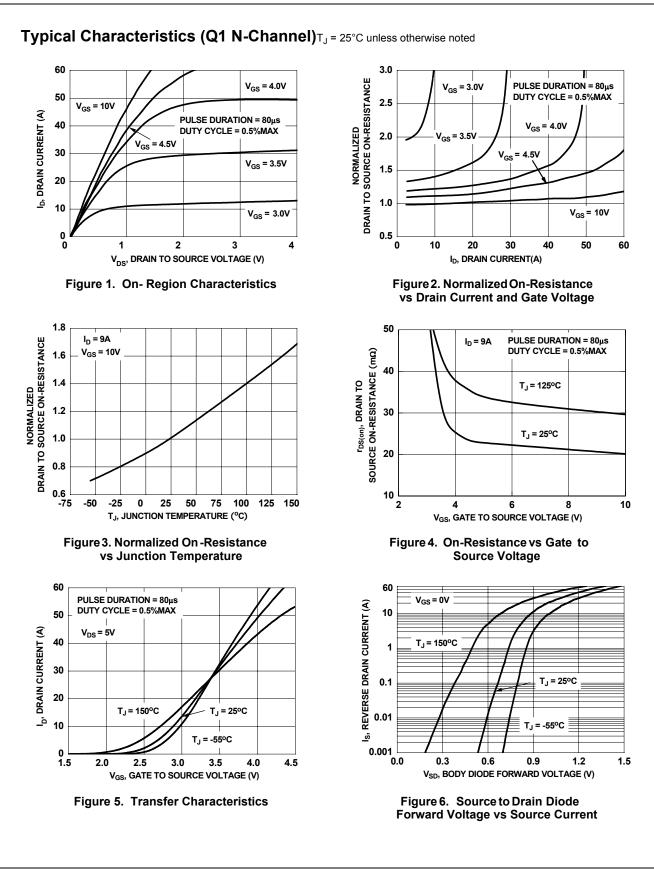
Symbol	Parameter	Test Conditions		Туре	Min	Тур	Max	Units
Drain-Sou	Irce Diode Characteristics							
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0V, I _S = 9.0A V _{GS} = 0V, I _S = -6.5A	(Note 2) (Note 2)	Q1 Q2		0.87 0.88	1.2 -1.2	V
t _{rr}	Reverse Recovery Time	Q1 I _F = 9.0A, di/dt = 100A/s		Q1 Q2		25 29	38 44	ns
Q _{rr}	Reverse Recovery Charge	Q2 I _F = -6.5A, di/dt = 100A/s		Q1 Q2		19 29	29 44	nC

Notes:

1. $R_{\theta JA}$ is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

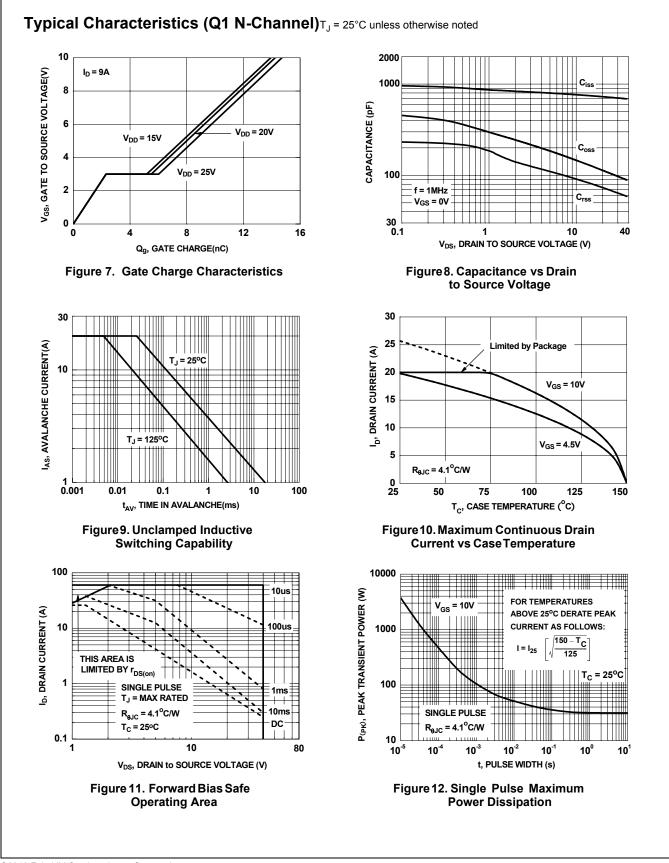






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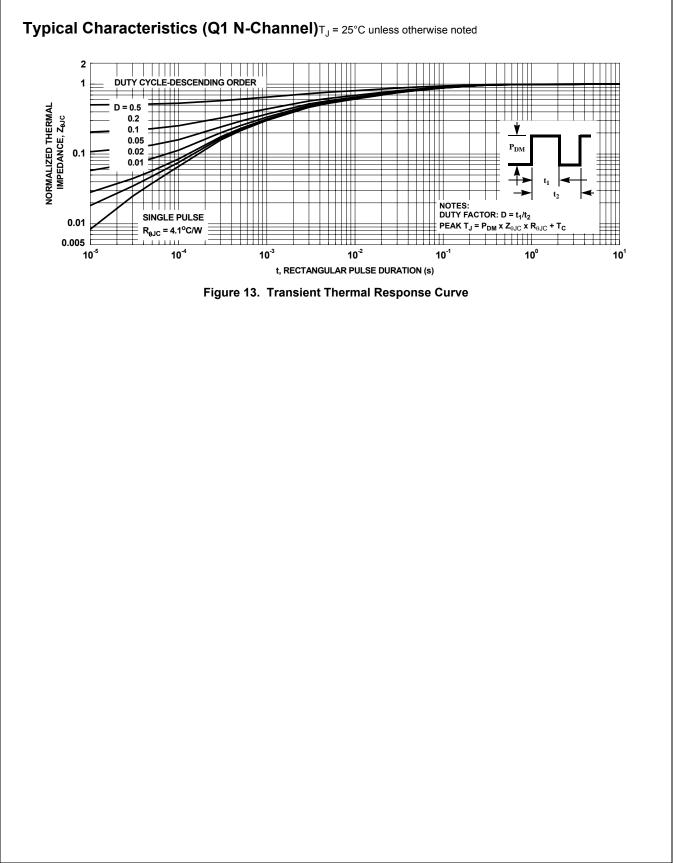
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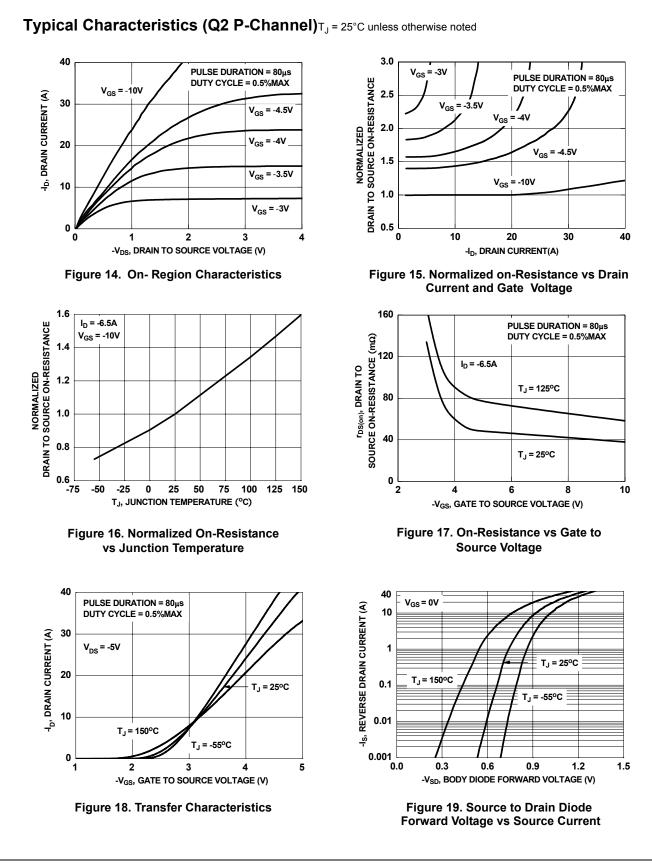


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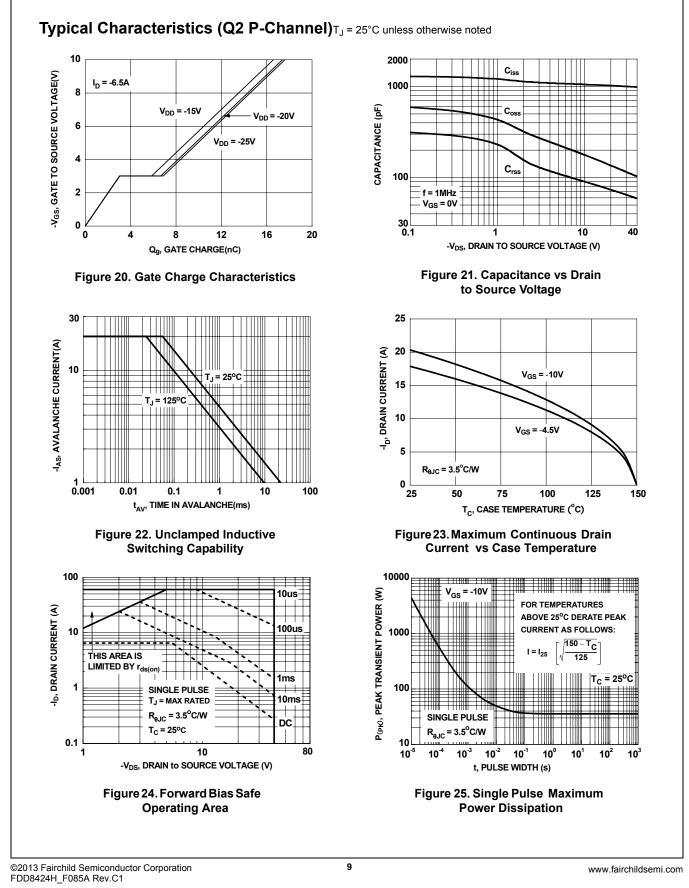
FDD8424H_F085A Dual N & P-Channel PowerTrench[®] MOSFET



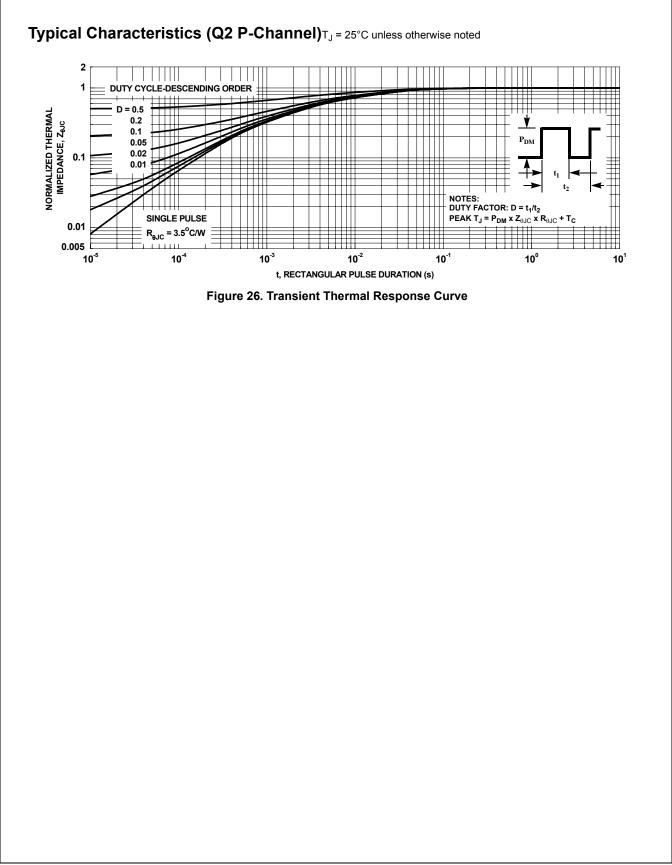


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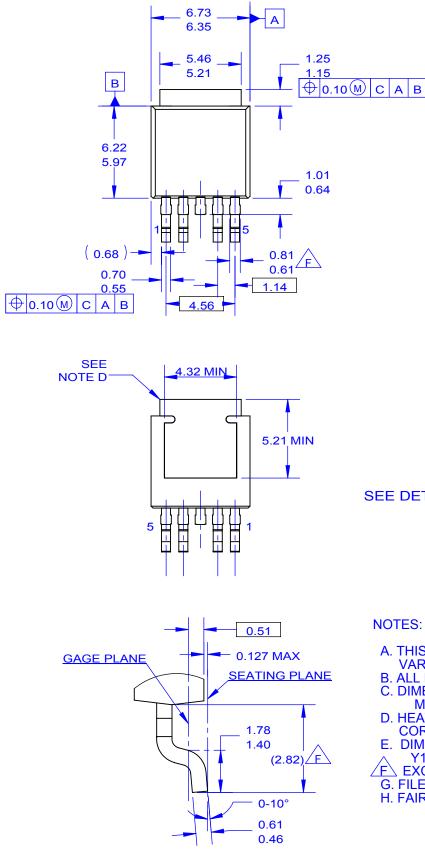
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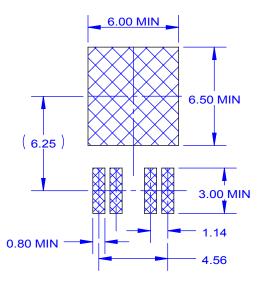
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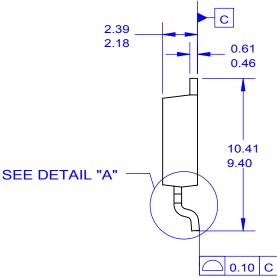


FDD8424H_F085A Dual N & P-Channel PowerTrench[®] MOSFET



DETAIL A SCALE 2:1





NOTES: UNLESS OTHERWISE SPECIFED

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